Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/708,849	SHIH ET AL.	
Examiner	Art Unit	
Thien F. Tran	2811	_

SEARCHED					
Class	Subclass	Date	Examiner		
257	13,59 72,79 82-84 88	10/13/2005	π		
345	76,82	10/30/2005	π		
345	92	10/30/2005	π		
		,			

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
			. <u>-</u> .		
			:		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST	10/13/2005	π	
EAST	10/30/2005	TT	
Interference Search History Printout	10/30/2005	π	